Ref#	Hits	Search Query	DBs	Default	Plurals	Time Stamp
SI	6	("3752952" "3409799").PN.	US-PGPUB;	Operator OR	OFF	2005/05/22 13:25
31		(3732932 3409799).EN.	USPAT; EPO; JPO; DERWENT ; IBM_TDB	OK	OFF	2003/03/22 13.23
S2	18	"3752952" "3409799"	US-PGPUB; USPAT; EPO; IPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 13:05
\$3	1272	electron adj beam and (beam near4 profile)	US-PGPUB; USPAT; EPO; IPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 14:05
S4	553	(electron adj beam and (beam near4 profile)) and (target or reticle)	US-PGPUB; USPAT; EPO; IPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 13:07
S5	31	((electron adj beam and (beam near4 profile)) and (target or reticle)) and back adj scatter\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 14:05
S6	48	(electron adj beam and (beam near4 profile)) and back adj scatter\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:25
S7	29	(electron adj beam and test adj pattern) and back adj scatter\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 19:18
S8	14612	electron adj beam and weld\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:25
S9	90	electron adj beam and weld\$3 and backscatter\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 14:33
S10	19	(electron adj beam and weld\$3 and backscatter\$3) and spot adj (size or shape)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:42
S11	90	(electron adj beam) and weld\$3 and backscatter\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 14:33
S12	0	(electron adj beam and weld\$3 and backscatter\$3) and spot adj (profile or uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 14:42
S13	2	(electron adj beam and weld\$3 and backscatter\$3) and beam adj (profile or uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:08

					1	2021/00/00 11 22
S14	911	electron adj beam and test adj pattern	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:33
S15	23	(electron adj microscope and test adj pattern) and back adj scatter\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 18:50
S16	2996	(electron adj microscope and slit)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 19:26
S17	59	(electron adj microscope and slit) and beam adj profile	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/27 19:32
S18	4	(electron adj microscope and slit) and (electron near4 beam adj profile)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:24
S19	10030	(electron adj microscope and (needle or raised))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:26
S20	3778	(electron adj microscope and (needle))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:27
S21	72	(electron adj microscope and (needle near4 tungsten))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:27
S22	56	(electron adj microscope and (needle near2 tungsten))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:28
S23	0	electron adj beam and (test adj pattern) near4 needle	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:34
S24	0	electron adj beam and (test adj pattern) near4 raised	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:35
S25	12080	electron adj beam and grid	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:35
S26	1707	electron adj beam and grid and distortion	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 14:35
S27	16	electron adj beam and grid and distortion near measurement	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 17:16

S28	17	"6204509"	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2004/09/28 17:02
S29	64	electron adj beam and grid and distortion WITH measurement	; IBM_TDB US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/09/28 17:17
S30	16	(electron adj beam and weld\$3 and backscatter\$3) and image and target	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF .	2004/10/07 15:51
S31	31	(electron adj beam and weld\$3 and backscatter\$3) and image	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 15:57
S32	6	(electron adj beam and machining and backscatter\$3) and beam adj (profile or uniformity)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:38
S33	0	electron adj beam WITH milling and back-scattered	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:14
S34	13	(electron adj beam WITH milling) and backscattered	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:34
S35	5087	(electron adj beam)and beam near control\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR .	OFF	2004/10/07 16:35
S36	10367	(electron adj beam)and beam near2 control\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:36
S37	3751	(electron adj beam)and beam adj control\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:36
S38	2043	(electron adj beam) and beam adj control	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:36
S39	0	((electron adj beam and weld\$3 and backscatter\$3) and image) and ((electron adj beam) and beam adj control)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:19
\$40	362	electron adj beam WITH milling	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 16:57
S41	71	(electron adj beam WITH milling) and (backscattered or secondary)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 17:05

S42	36	(electron adj beam WITH milling) and (backscattered or secondary) and measur\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 17:28
S43	14	(electron adj beam WITH repair) and (backscattered or secondary) and measur\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/07 17:28
S44	2354	((electron adj beam and weld\$3) and image)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:20
S45	71	(((electron adj beam and weld\$3) and image)) and segmented	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:28
S46	1	(((electron adj beam and weld\$3) and image)) and sensor adj ring	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:31
S47	21	(((electron adj beam and weld\$3) and image)) and sensor WITH ring	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:31

S48	215	(US-6524873-\$ or US-6566885-\$ or US-6576923-\$ or US-6603120-\$ or	US-PGPUB;	OR	OFF	2004/10/11 15:3
- 1		US-6633174-\$ or US-6636064-\$ or US-6670602-\$ or US-6749346-\$ or	USPAT;		ł	
		US-6771806-S or US-5770883-S or US-6734611-S or US-6268118-S or	EPO; JPO;			
- 1		US-6204509-\$ or US-6787780-\$ or US-6008800-\$ or US-5982352-\$ or	DERWENT			
		US-6703624-\$ or US-6591658-\$ or US-6375768-\$ or US-6180570-\$ or				
- 1		US-6354133-\$ or US-5374826-\$ or US-5051600-\$ or US-3798453-\$ or				
- 1		US-6326619-\$ or US-4950940-\$).did. or (US-5043583-\$ or US-4794259-\$			ļ	
		or US-4908545-\$ or US-4178529-\$ or US-4179604-\$ or US-4178528-\$ or				
		US-5077774-\$ or US-6700127-\$ or US-6670610-\$ or US-5900667-\$ or				
		US-4999234-S or US-4888260-S or US-4874213-S or US-4839250-S or				
- 1		US-4301237-\$ or US-4260670-\$ or US-6542576-\$ or US-6180289-\$ or				1
l l		US-6171736-\$ or US-6114695-\$ or US-5986765-\$ or US-5969357-\$ or				
		US-5888682-\$ or US-5866904-\$ or US-5554926-\$ or US-5594245-\$ or				
ĺ		US-5468966-\$).did. or (US-5382895-\$ or US-6563591-\$ or US-6377657-\$				
		or US-6399258-\$ or US-6317216-\$ or US-6303931-\$ or US-6174801-\$ or				
		US-5825040-\$ or US-4634645-\$ or US-5759423-\$ or US-6714620-\$ or				
		US-6617587-\$ or US-6203952-\$ or US-6593152-\$ or US-6333510-\$ or				
		US-5969365-\$ or US-6242751-\$ or US-5757015-\$ or US-6107637-\$ or				
		US-5414330-\$ or US-4774460-\$ or US-4989072-\$ or US-6429440-\$ or				
		US-6417516-\$ or US-3816848-\$ or US-3673412-\$ or US-3937959-\$).did. or				
		(US-3875585-\$ or US-4325082-\$ or US-4587464-\$ or US-4400609-\$ or				
		US-4654506-\$ or US-4929836-\$ or US-6333968-\$ or US-3752952-\$ or				
		US-3602765-\$ or US-6636311-\$ or US-6753518-\$ or US-6489091-\$ or			}	
		US-5216631-\$ or US-5307311-\$ or US-5647883-\$ or US-5616921-\$ or				
i		US-4316093-\$ or US-4299911-\$ or US-4197332-\$ or US-6753538-\$ or				
- 1		US-4906326-\$ or US-4979223-\$ or US-6514289-\$ or US-6424697-\$ or				
		US-6459090-\$ or US-6534222-\$ or US-3633065-\$).did. or (US-5825033-\$				ĺ
1		or US-5158491-\$ or US-3666985-\$ or US-6787783-\$ or US-6661009-\$ or				
		US-6537310-\$ or US-6507044-\$ or US-5846447-\$ or US-5821556-\$ or			ŀ	
1		US-5770309-\$ or US-5674307-\$ or US-5960058-\$ or US-5978085-\$ or				1
1		US-5878108-\$ or US-5798947-\$ or US-6091187-\$ or US-5011755-\$ or				
		US-6166380-\$ or US-5360764-\$ or US-5130539-\$ or US-3644700-\$ or				
		US-6445199-\$ or US-6509197-\$ or US-6184160-\$ or US-6321114-\$ or				
		US-6445948-\$ or US-6459566-\$).did. or (US-6493212-\$ or US-5241185-\$				
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		US-6154305-\$ or US-6433561-\$ or US-6099600-\$ or US-6141205-\$ or				
		US-6157531-\$ or US-6212063-\$ or US-6009348-\$ or US-6118652-\$ or			ļ	
	•	US-6042624-\$ or US-6006133-\$ or US-6032075-\$).did. or		1	1	
		(US-20030032039-\$ or US-20030038579-\$ or US-20010028046-\$ or				,
		US-20030189180-\$ or US-20010028043-\$ or US-20010028044-\$ or				
		US-20010028038-\$ or US-20010028042-\$ or US-20040197471-\$ or				
		US-20040173747-\$ or US-20040061051-\$ or US-20030127594-\$ or				
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		US-20030132196-\$ or US-20030130718-\$ or US-20030061687-\$ or				
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		US-20010006766-\$ or US-20030155927-\$ or US-20030071213-\$ or				
		US-20030096436-\$ or US-20020187582-\$).did. or (US-20020148961-\$ or				
		US-20010054697-\$ or US-20040069945-\$ or US-20020142496-\$ or		1	Ì	
		US-20020109090-\$ or US-20020106054-\$ or US-20020106056-\$ or			l	
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		US-20040119021-\$ or US-20040013954-\$ or US-20030183763-\$ or			Ì	
		US-20030207475-\$ or US-20030168594-\$ or US-20030085360-\$ or			ļ	
		US-20020173085-\$ or US-20010041313-\$ or US-20020053634-\$ or		l	Ì	
		US-20010013581-\$ or US-20040100421-\$ or US-20030000921-\$ or				
		US-20020085679-\$ or US-20040183013-\$ or US-200300074053-\$ or				
		US-20020083679-\$ or US-20040183013-\$ or US-20030074035-\$ or US-20020074494-\$).did. or (US-20040059444-\$ or				
		US-20030088293-\$ or US-20040151466-\$).did. or (DE-3718177-\$ or		I	1	
		DE-3409799-\$).did. or (JP-2000195460-\$).did. or (JP-06028985-\$ or				1
1		DE-3409799-\$).aid. or (JP-2000193460-\$).aid. or (JP-06028983-\$ or DE-3409799-\$ or DE-2013950-\$ or JP-11142121-\$ or SU-1024572-\$).did.				
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S50 29	(US-6524873-S or US-6566885-S or US-6576923-S or US-6603120-S or US-6633174-S or US-6636064-S or US-670602-S or US-6749346-S or US-67371806-S or US-57770883-S or US-673611-S or US-5268118-S or US-673609-S or US-6787780-S or US-6008800-S or US-578252-S or US-67303624-S or US-597878780-S or US-6008800-S or US-578252-S or US-67303624-S or US-597878780-S or US-6008800-S or US-5798252-S or US-6703624-S or US-5978785-S or US-6703624-S or US-3787878-S or US-4794259-S or US-439691-S or US-499090-S). did or (US-504383-S or US-4794259-S or US-43908545-S or US-4178529-S or US-4179604-S or US-4794259-S or US-49908545-S or US-4798259-S or US-479604-S or US-49908545-S or US-4788260-S or US-479604-S or US-49908545-S or US-488260-S or US-4874213-S or US-499025-S or US-4390123-S or US-4260670-S or US-642576-S or US-5990667-S or US-439123-S or US-460670-S or US-5986765-S or US-599357-S or US-5888662-S or US-5866904-S or US-5986765-S or US-599357-S or US-5888662-S or US-5866904-S or US-5986765-S or US-599357-S or US-5888662-S or US-5866904-S or US-5986765-S or US-6477657-S or US-5888662-S or US-5866904-S or US-5953152-S or US-6377657-S or US-657765-S or US-6477657-S or US-647767-S or US-647776-S or US-6477777-S or US-647777-S or US-647777-S or US-647777-S or US-647777-S	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:38
	and test adj pattern				
S51 750	weld near4 image	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:42
852 30	weld near4 image and electron adj beam	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:43
S53 5	weld near4 image and electron adj beam and segment\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:43

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S54	2	(electron adj_microscope and test adj pattern) and usaf	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:55
S55	25	(electron adj microscope) and usaf	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 15:59
S56	195	segmented adj detector .	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 16:00
S57	25	segmented adj detector and electron adj beam	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 16:00
S58	5	"4794259"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:23
S59	3129	(250/397 250/398 250/307 216/39).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:24
S60	14	((250/397 250/398 250/307 216/39).ccls.) and (electron adj beam and (beam near4 profile)) and back adj scatter\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:25
S61	68	((250/397 250/398 250/307 216/39).ccls.) and electron adj beam and weld\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:26
S62	35	(((250/397 250/398 250/307 216/39).ccls.) and electron adj beam and weld\$3) and image	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2004/10/11 21:26
S69		lower.in. and electron adj beam	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:28
S70	1 .	lower.in. and electron adj beam	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:39
S71	15409	weld\$3 and electron adj beam	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:40
S72	70	weld\$3 and electron adj beam and (250/397 250/398 250/307 216/39).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:50
S73	1	weld\$3 and electron adj beam and (216/39).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:44

S74	67	weld\$3 and electron adj beam and ("216"/\$).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:45
S76	14	(electron adj beam near3 weld\$3) and ("216"/\$).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:46
S77	69	weld\$3 and electron adj beam and (250/397 250/398 250/307).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:50
S78	6	weld\$3 and (electron adj beam near (profile or uniformity)) and (250/397 250/398 250/307).ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/05/22 13:51